

<b>Notice of References Cited</b>	Application/Control No. 09/494,514		Applicant(s)/Patent Under Reexamination NAVEEN ET AL.	
	Examiner John B. Strege		Art Unit 2625	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,011,865	01-2000	Fujisaki et al.	382/189
*	B	US-5,485,531	01-1996	Ichinohe et al.	382/198
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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